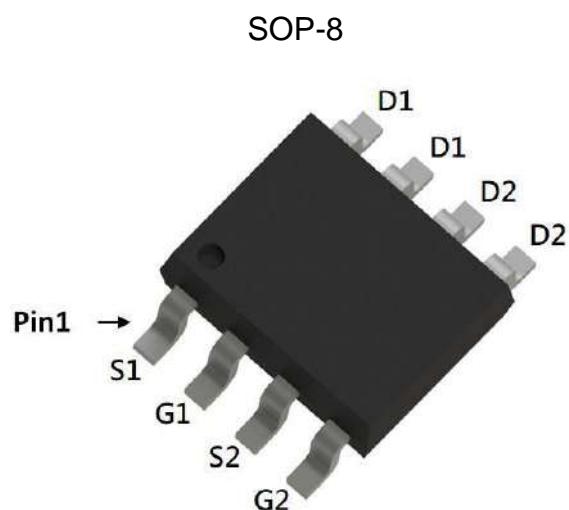


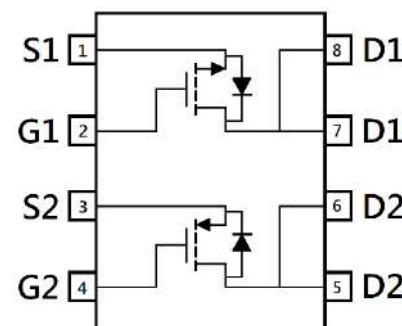
N- AND P-Channel Enhancement Mode Power MOSFET

Features:

- Low On Resistance
- Low Gate Charge
- Fast Switching Characteristic



	N-CH	P-CH
BV _{DSS}	40V	-40V
I _D @V _{GS} =(-)10V, T _C =25°C	13.5A	-9A
I _D @V _{GS} =(-)10V, T _A =25°C	5.8A	-3.8A
R _{D(S)} (ON)typ. @ V _{GS} =(-)10V	17mΩ	40mΩ
R _{D(S)} (ON)typ. @ V _{GS} =(-)4.5V	25mΩ	56mΩ



G : Gate S : Source D : Drain

Ordering Information

Device	Package	Shipping
KSCB020C04R	SOP-8 (RoHS compliant & Halogen-free package)	4000 pcs / Tape & Reel

Absolute Maximum Ratings ($T_A=25^\circ\text{C}$)

Parameter	Symbol	Limits		Unit	
		N-CH	P-CH		
Drain-Source Voltage	V_{DS}	40	-40	V	
Gate-Source Voltage	V_{GS}	± 20	± 20		
Continuous Drain Current @ $V_{GS}=(-)10\text{V}$, $T_C=25^\circ\text{C}$	I_D	13.5	-9		
Continuous Drain Current @ $V_{GS}=(-)10\text{V}$, $T_C=100^\circ\text{C}$		8.5	-5.7		
Continuous Drain Current @ $V_{GS}=(-)10\text{V}$, $T_A=25^\circ\text{C}$		5.8	-3.8		
Continuous Drain Current @ $V_{GS}=(-)10\text{V}$, $T_A=70^\circ\text{C}$		4.6	-3		
Pulsed Drain Current	I_{DM}	24	-16	A	
Continuous Body Diode Forward Current @ $T_C=25^\circ\text{C}$	I_S	6	-6		
Avalanche Current @ $L=0.1\text{mH}$	I_{AS}	5	-15		
Avalanche Energy @ $L=0.5\text{mH}$	E_{AS}	4	16		
Total Power Dissipation	P_D	$T_C=25^\circ\text{C}$		W	
		$T_C=100^\circ\text{C}$			
		$T_A=25^\circ\text{C}$			
		$T_A=70^\circ\text{C}$			
Operating Junction and Storage Temperature Range	T_J, T_{stg}	$-55\text{~}+150$		$^\circ\text{C}$	

Thermal Data

Parameter	Symbol	Steady State	Unit
Thermal Resistance, Junction-to-case	$R_{\theta JC}$	17	$^\circ\text{C}/\text{W}$
Thermal Resistance, Junction-to-ambient	$R_{\theta JA}$	90	

Note:

- *a. The power dissipation P_D is based on $T_{J(MAX)}=150^\circ\text{C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- *b. The value of $R_{\theta JA}$ is measured with the device mounted on 1 in² FR -4 board with 2 oz. copper, in a still air environment with $T_A=25^\circ\text{C}$. The power dissipation P_D is based on $R_{\theta JA}$ and the maximum allowed junction temperature of 150°C . The value in any given application depends on the user's specific board design.
- *c. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}=150^\circ\text{C}$. Ratings are based on low frequency and low duty cycles to keep initial $T_J=25^\circ\text{C}$.

N-Channel Electrical Characteristics ($T_A=25^\circ\text{C}$, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV _{DSS}	40	-	-	V	V _{GS} =0V, I _D =250μA
V _{GS(th)}	1	-	2.5		V _{DS} =V _{GS} , I _D =250μA
G _{FS}	-	7.5	-	S	V _{DS} =5V, I _D =5A
I _{GSS}	-	-	±100	nA	V _{GS} =±20V, V _{DS} =0V
I _{DSS}	-	-	1	μA	V _{DS} =32V, V _{GS} =0V
R _{DSD(ON)}	-	17	22	mΩ	V _{GS} =10V, I _D =6A
	-	25	35		V _{GS} =4.5V, I _D =5A
Dynamic					
C _{iss}	-	275	-	pF	V _{DS} =20V, V _{GS} =0V, f=1MHz
C _{oss}	-	135	-		
C _{rss}	-	23	-	nC	V _{DS} =20V, I _D =5A, V _{GS} =10V
R _g	-	0.4	-		
Q _g *1, 2	-	5.5	-	ns	V _{DS} =20V, I _D =5A, V _{GS} =10V, R _{GS} =1Ω
Q _{gs} *1, 2	-	1	-		
Q _{gd} *1, 2	-	1	-	ns	V _{DS} =20V, I _D =5A, V _{GS} =10V, R _{GS} =1Ω
t _{d(ON)} *1, 2	-	4.5	-		
t _r *1, 2	-	14	-	ns	V _{DS} =20V, I _D =5A, V _{GS} =10V, R _{GS} =1Ω
t _{d(OFF)} *1, 2	-	13	-		
t _f *1, 2	-	5	-	ns	I _F =5A, dI _F /dt=100A/μs
Source-Drain Diode					
V _{SD} *1	-	0.85	1.2	V	I _S =5A, V _{GS} =0V
trr	-	9.3	-	ns	I _F =5A, dI _F /dt=100A/μs
Qrr	-	2.6	-	nC	

Note:

*1. Pulse Test : Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$

*2. Independent of operating temperature

P-Channel Electrical Characteristics ($T_A=25^\circ C$, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions		
Static							
BV_{DSS}	-40	-	-	V	$V_{GS}=0V, I_D=-250\mu A$		
$V_{GS(th)}$	-1	-	-2.5		$V_{DS}=V_{GS}, I_D=-250\mu A$		
G_{FS}	-	8	-	S	$V_{DS}=-10V, I_D=-4A$		
I_{GSS}	-	-	± 100	nA	$V_{GS}=\pm 20V, V_{DS}=0V$		
I_{DSS}	-	-	-1	μA	$V_{DS}=-32V, V_{GS}=0V$		
$R_{DS(ON)}$	-	40	52	m Ω	$V_{GS}=-10V, I_D=-4A$		
	-	56	78		$V_{GS}=-4.5V, I_D=-3A$		
Dynamic							
C_{iss}	-	930	-	pF	$V_{DS}=-20V, V_{GS}=0V, f=1MHz$		
C_{oss}	-	80	-				
C_{rss}	-	60	-	Ω	$f=1MHz$		
R_g	-	17	-				
Q_g *1, 2	-	19	-	nC	$V_{DS}=-20V, I_D=-3A, V_{GS}=-10V$		
Q_{gs} *1, 2	-	2.8	-				
Q_{gd} *1, 2	-	3.6	-	ns	$V_{DS}=-20V, I_D=-3A, V_{GS}=-10V, R_{GS}=1\Omega$		
$t_{d(ON)}$ *1, 2	-	6.8	-				
t_r *1, 2	-	19	-				
$t_{d(OFF)}$ *1, 2	-	65	-				
t_f *1, 2	-	31	-	nC	$I_F=-3A, dI_F/dt=100A/\mu s$		
Source-Drain Diode							
V_{SD} *1	-	-0.8	-1.2		V	$I_s=-3A, V_{GS}=0V$	
trr	-	9.5	-		ns		
Qrr	-	5	-		nC		

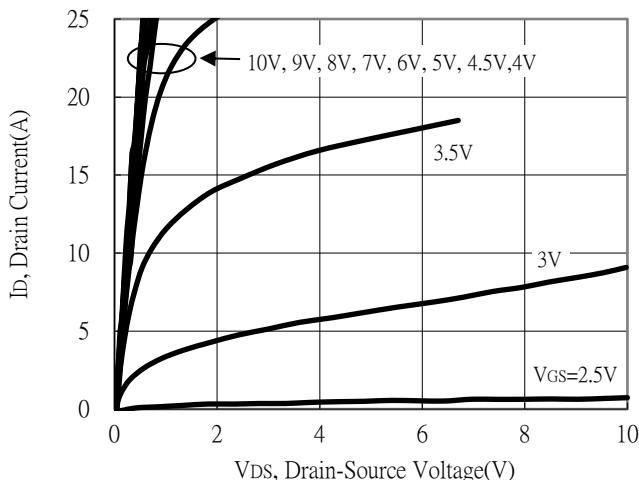
Note:

*1. Pulse Test : Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$

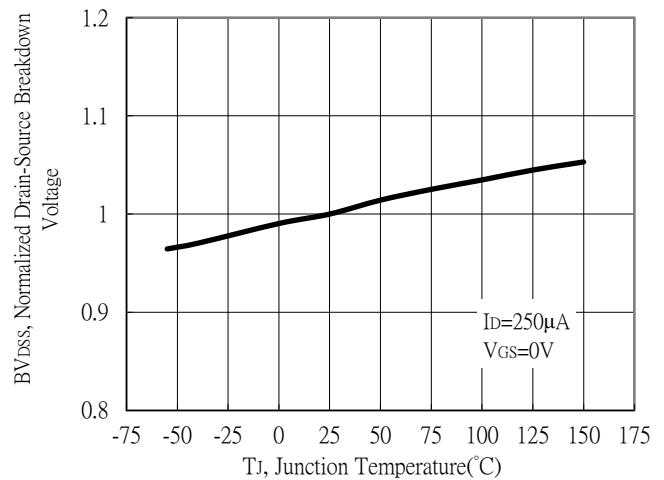
*2. Independent of operating temperature

Typical Characteristics : Q1(N-channel)

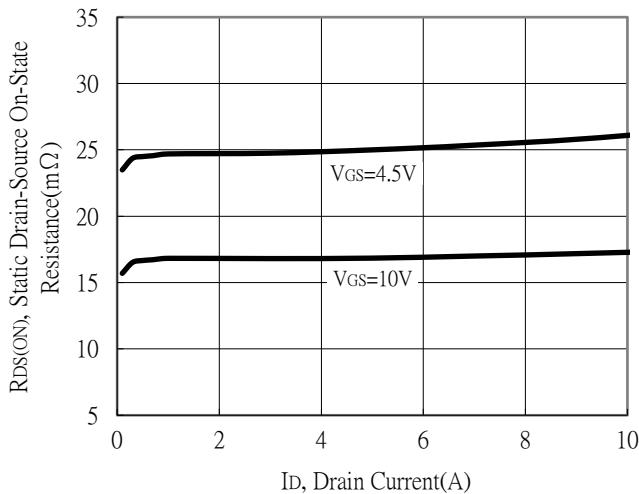
Typical Output Characteristics



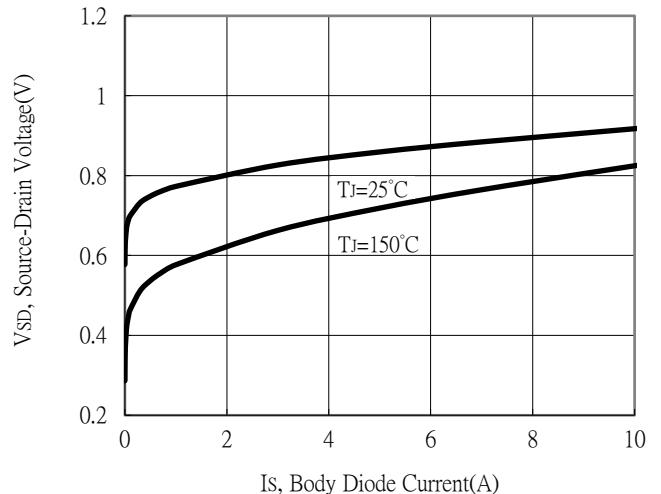
Breakdown Voltage vs Ambient Temperature



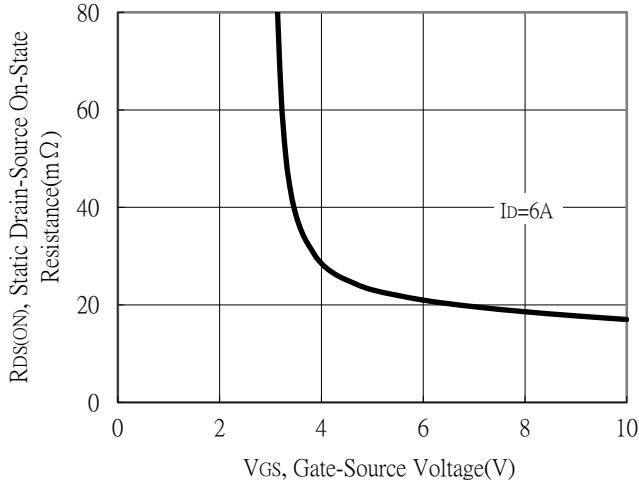
Static Drain-Source On-State resistance vs Drain Current



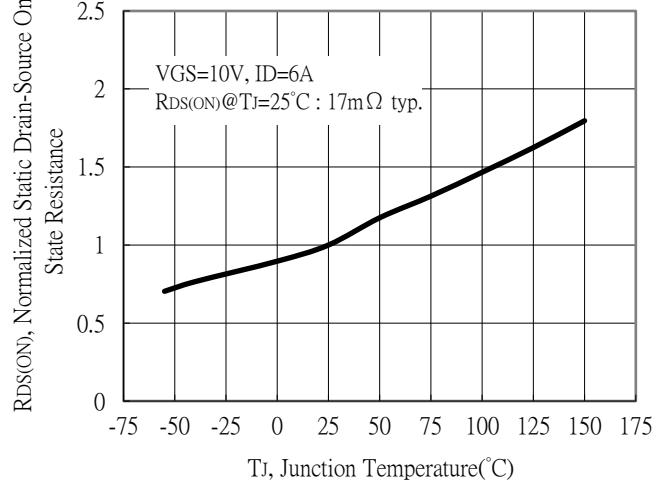
Body Diode Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

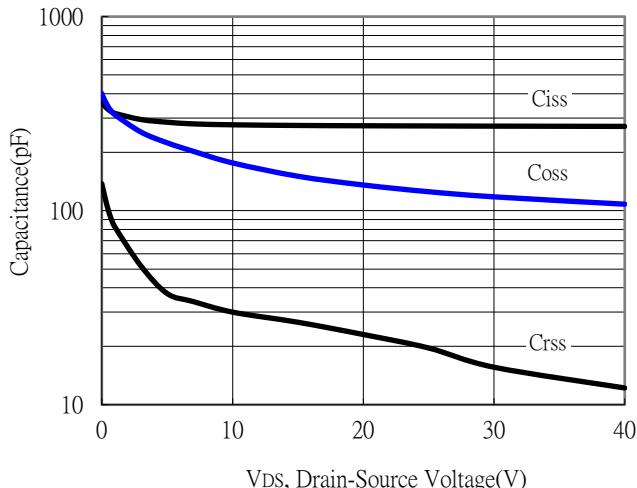


Drain-Source On-State Resistance vs Junction Temperature

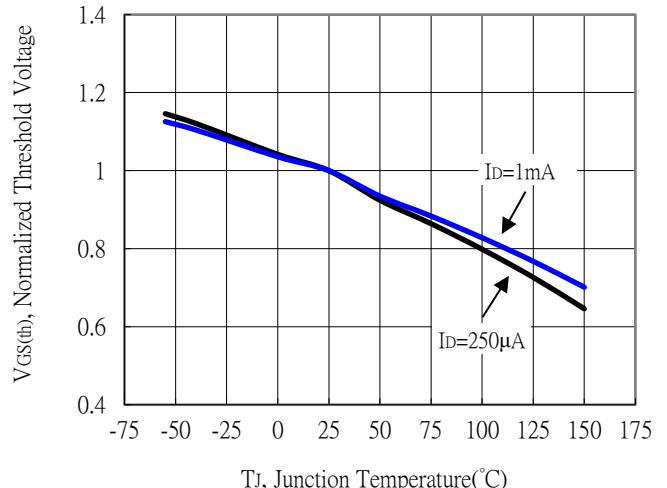


Typical Characteristics (Cont.) : Q1(N-channel)

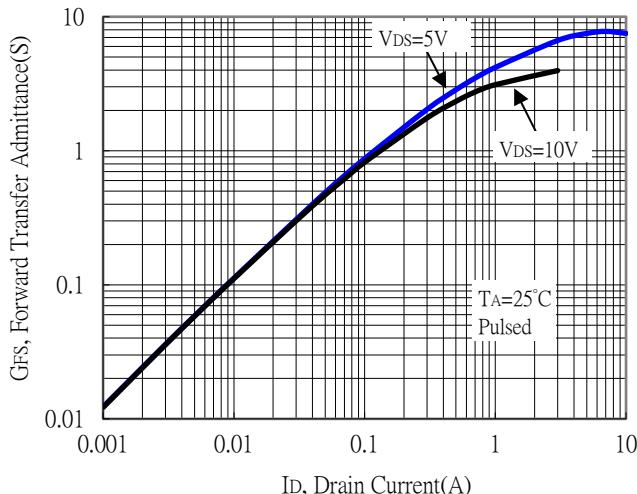
Capacitance vs Drain-to-Source Voltage



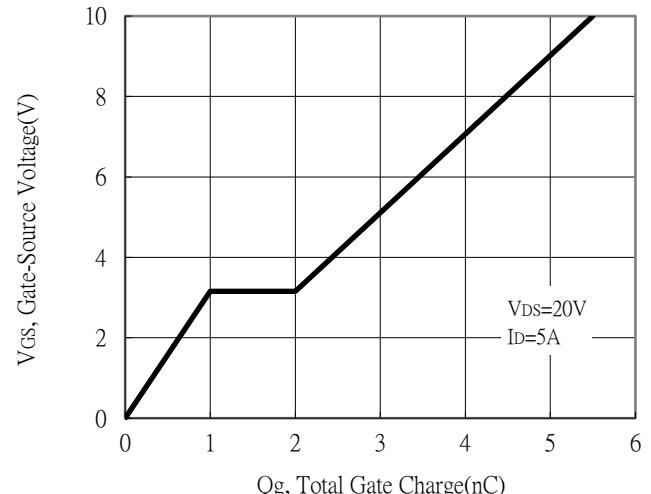
Threshold Voltage vs Junction Temperature



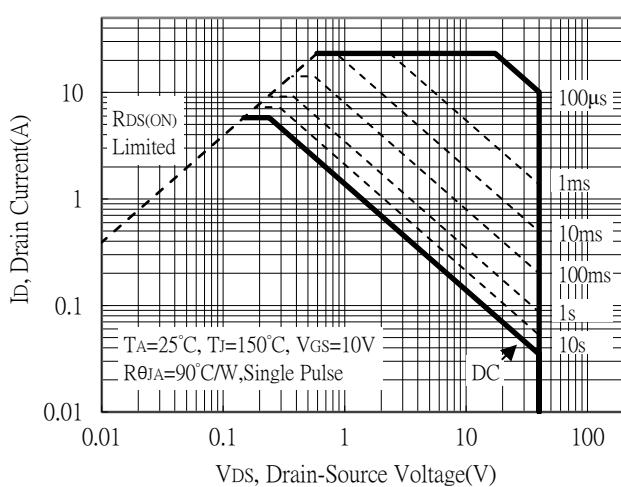
Forward Transfer Admittance vs Drain Current



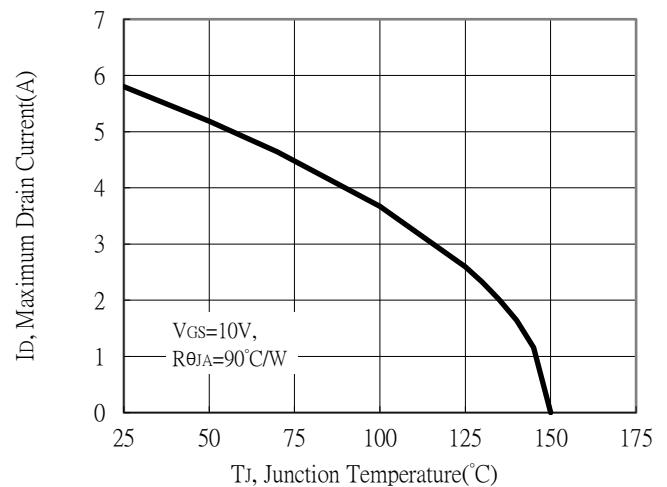
Gate Charge Characteristics



Maximum Safe Operating Area

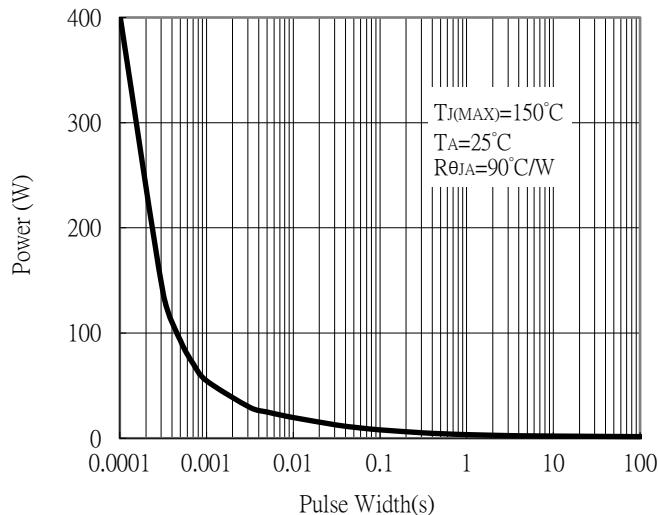


Maximum Drain Current vs Junction Temperature

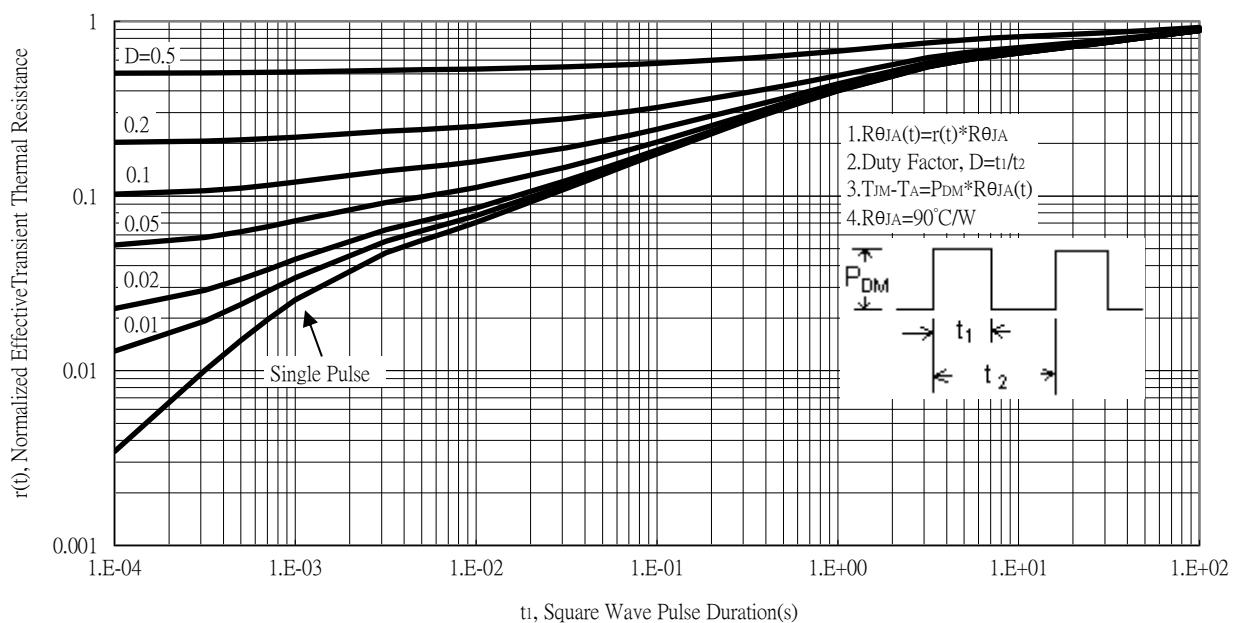


Typical Characteristics (Cont.) : Q1(N-channel)

Single Pulse Power Rating, Junction to Ambient

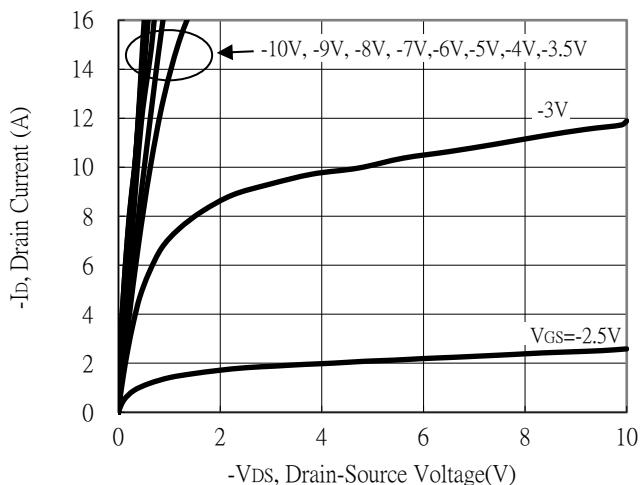


Transient Thermal Response Curves

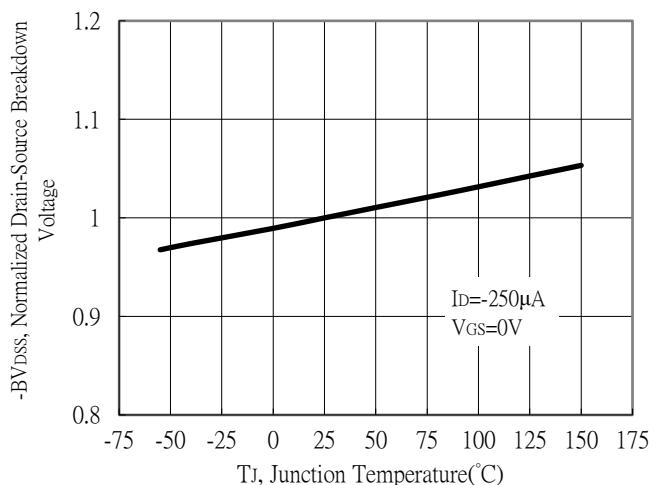


Typical Characteristics : Q2(P-channel)

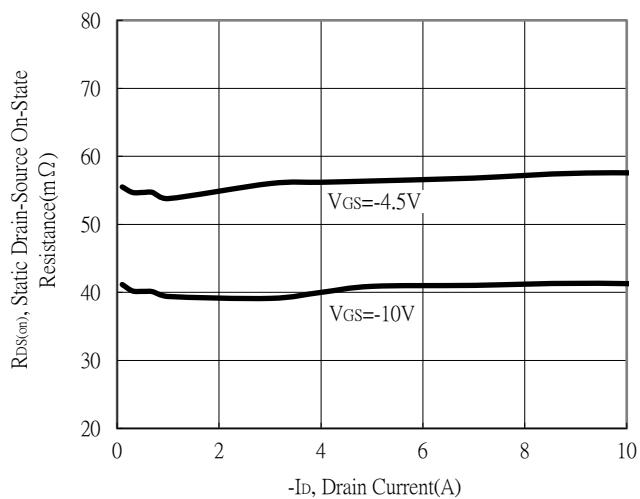
Typical Output Characteristics



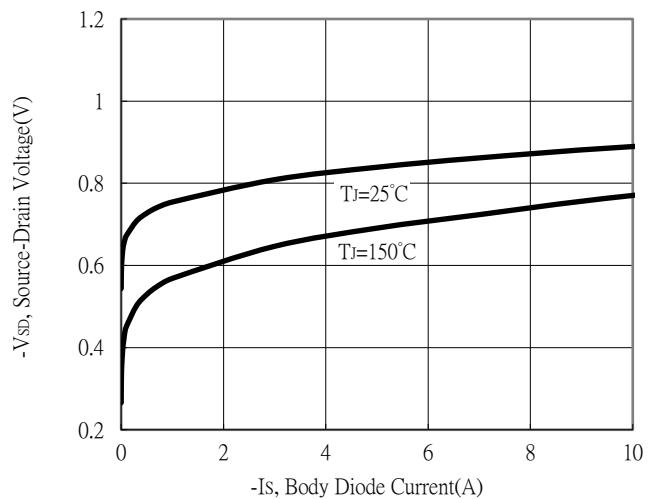
Breakdown Voltage vs Ambient Temperature



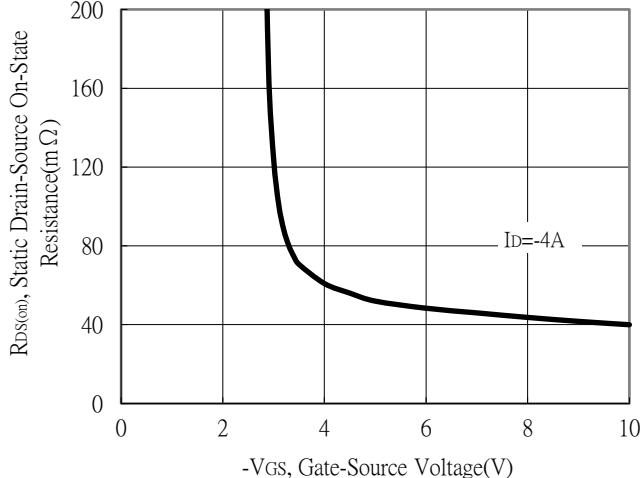
Static Drain-Source On-State resistance vs Drain Current



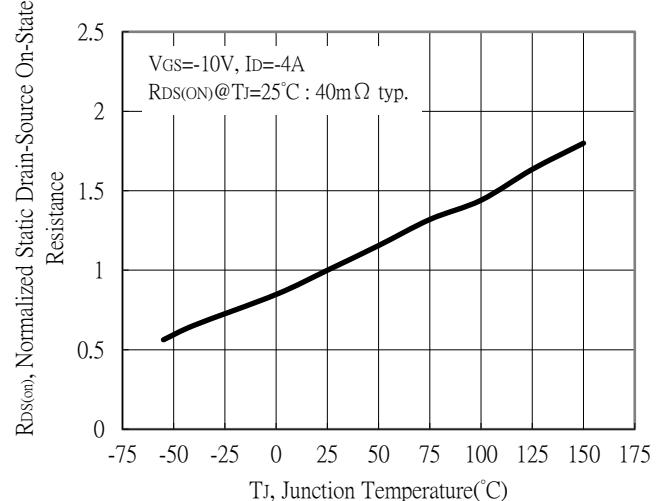
Body Diode Current vs Source-Drain Voltage



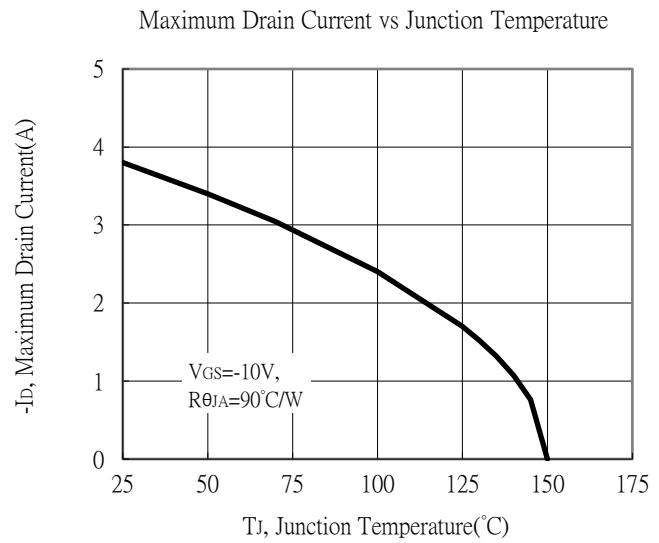
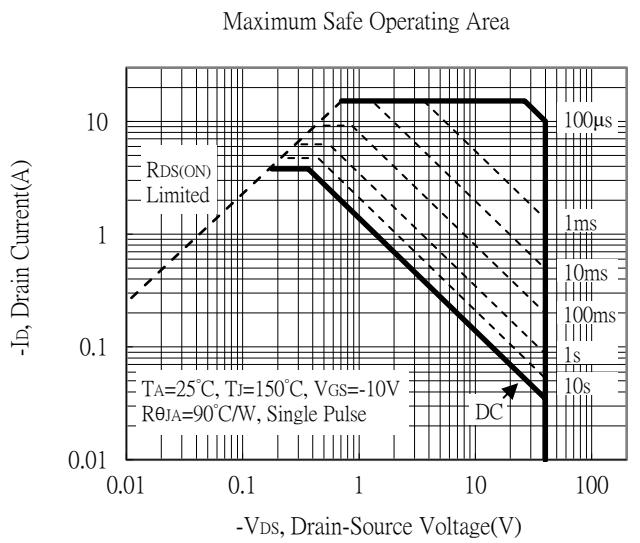
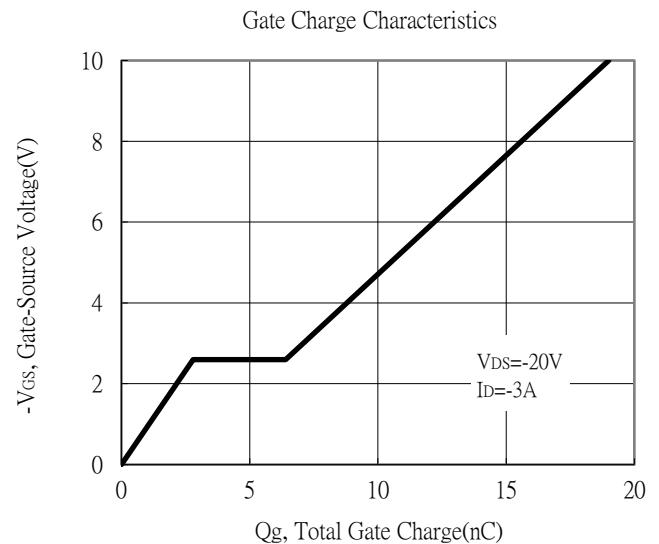
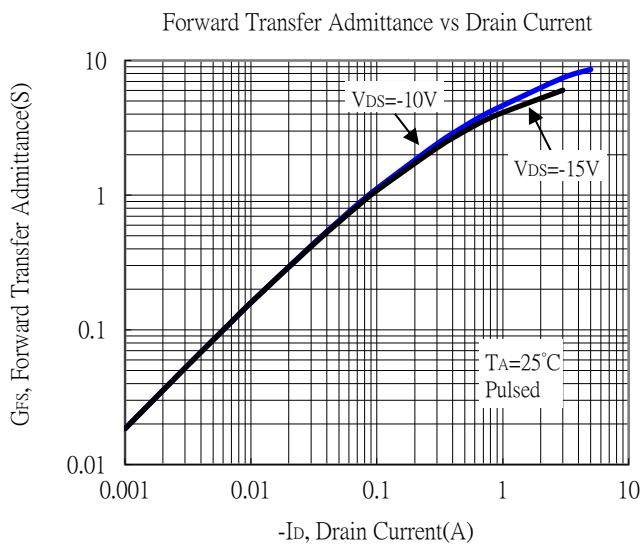
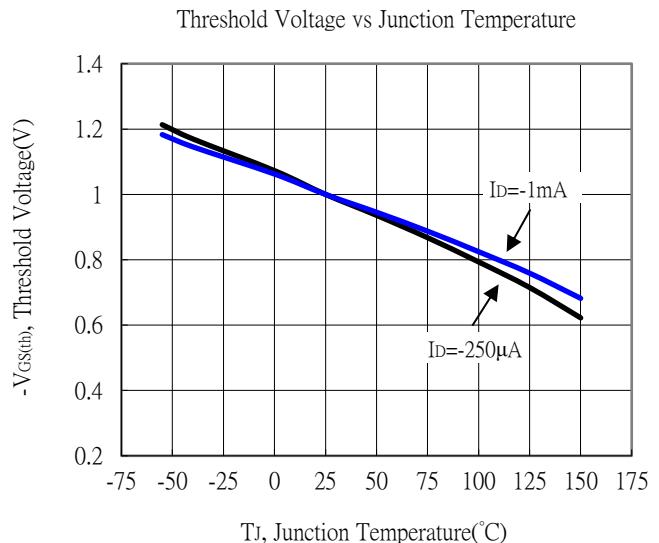
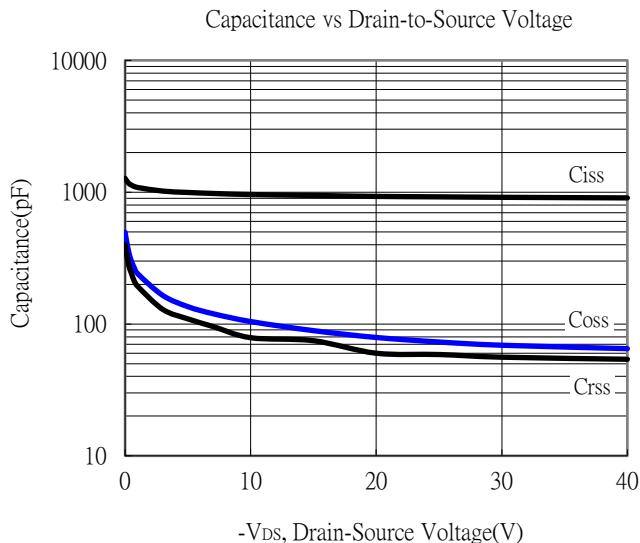
Static Drain-Source On-State Resistance vs Gate-Source Voltage



Drain-Source On-State Resistance vs Junction Temperature

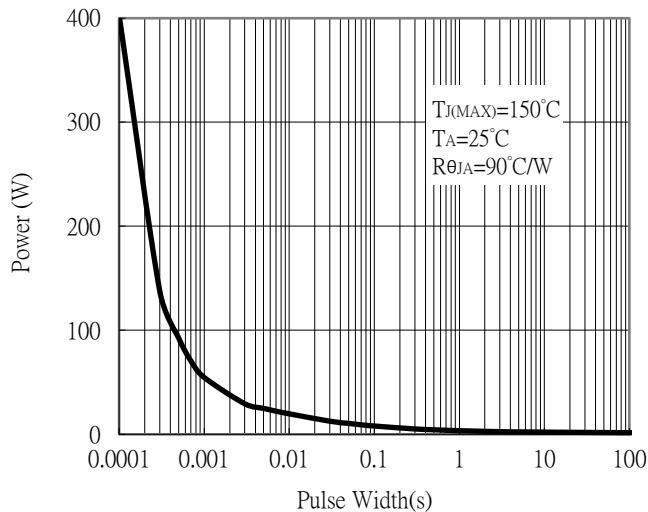


Typical Characteristics (Cont.) : Q2(P-channel)

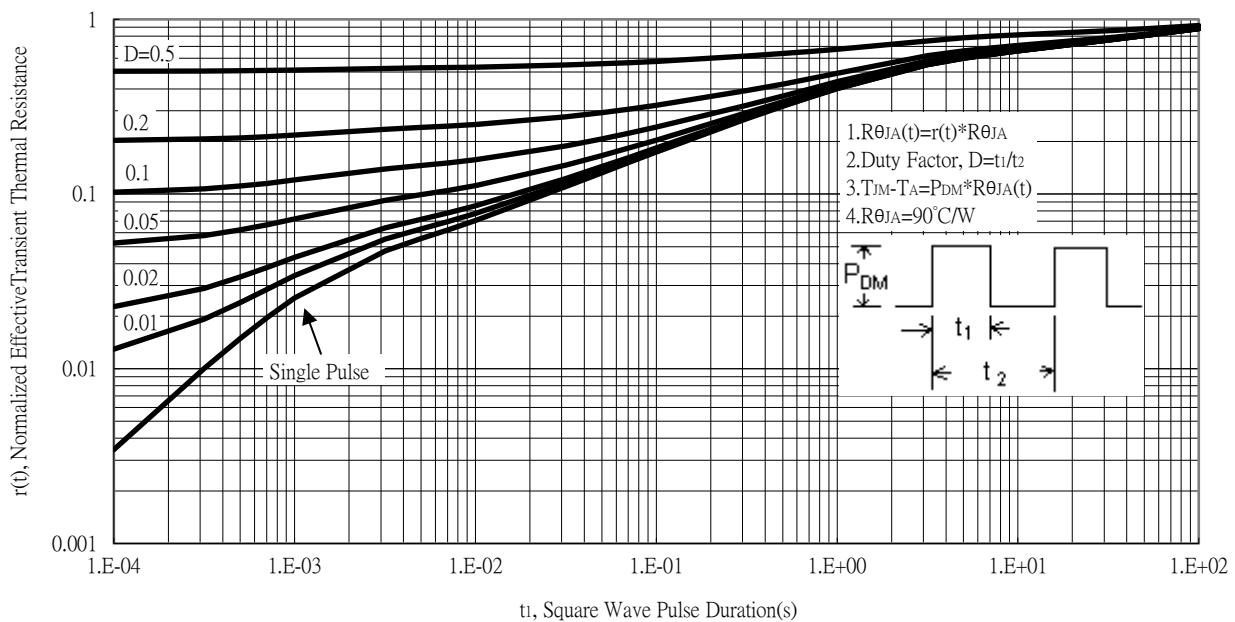


Typical Characteristics (Cont.) : Q2(P-channel)

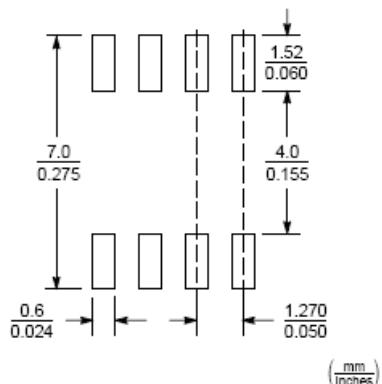
Single Pulse Power Rating, Junction to Ambient



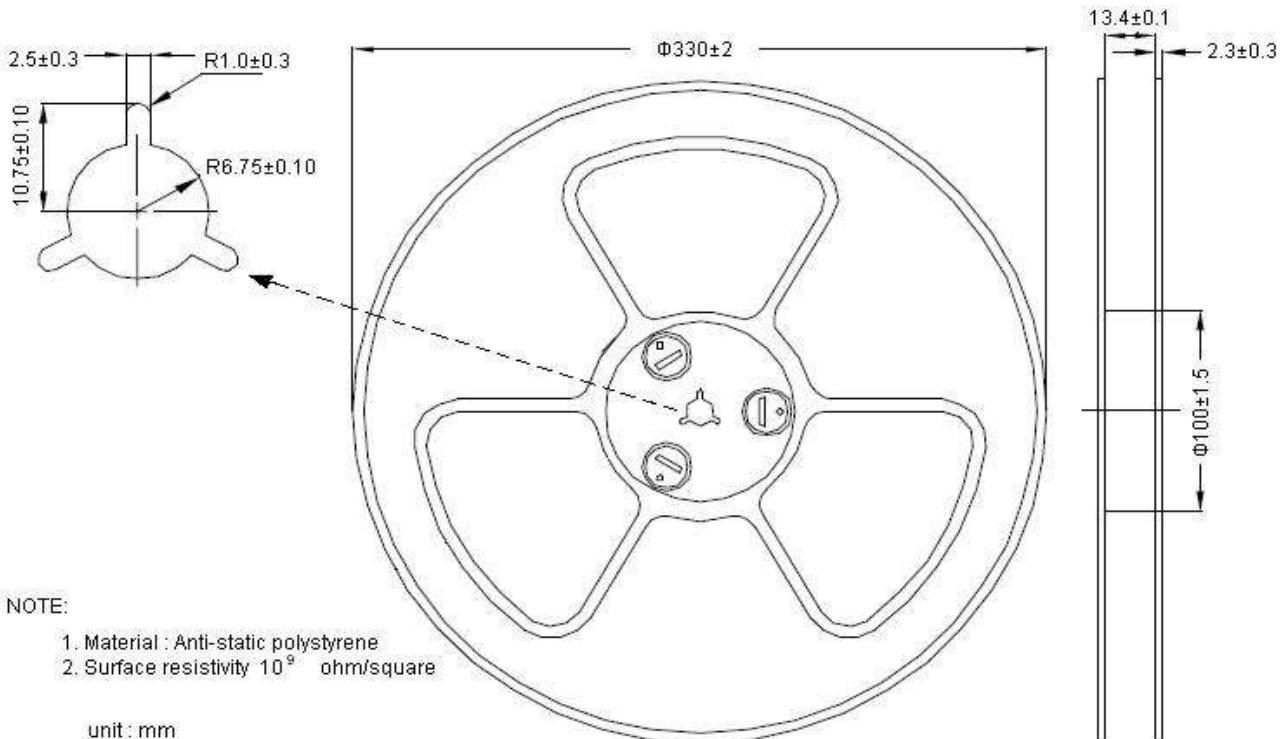
Transient Thermal Response Curves



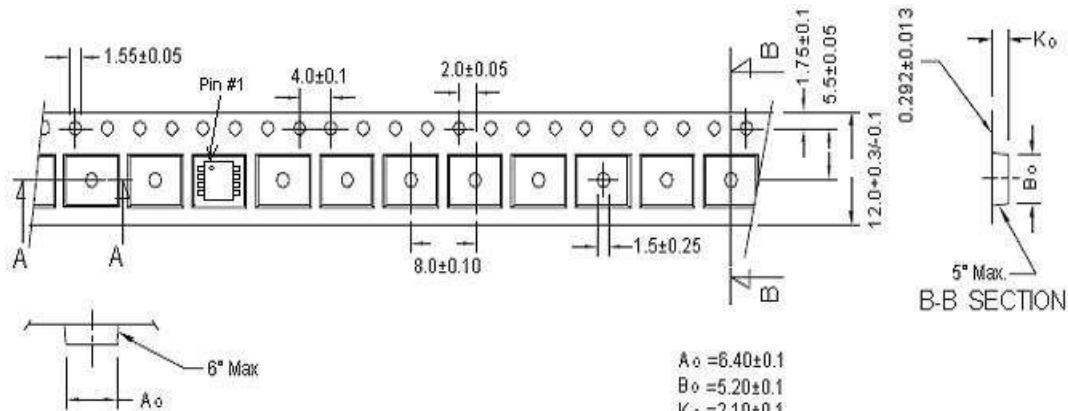
Recommended Soldering Footprint



Reel Dimension

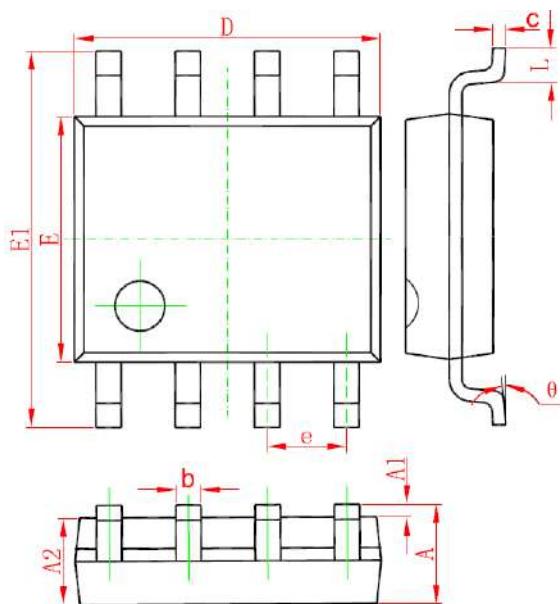


Carrier Tape Dimension

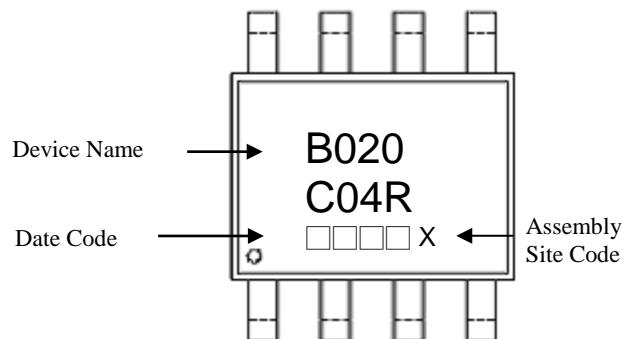


Uni : millimeter

SOP-8 Dimension



Marking:



Date Code(counting from left to right) :

1st code: year code, the last digit of Christian year

2nd code : month code, Jan→A, Feb→B, Mar→C, Apr→D

May→E, Jun→F, Jul→G, Aug→H, Sep→J,

Oct→K, Nov→L, Dec→M

3rd and 4th codes : production serial number, 01~99

Assembly Site Code : blank→ Site 1, G →Site 2

8-Lead SOP-8 Plastic Package

*: Typical

DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	1.350	1.750	0.053	0.069	E	3.800	4.000	0.150	0.157
A1	0.100	0.250	0.004	0.010	E1	5.800	6.200	0.228	0.244
A2	1.350	1.550	0.053	0.061	e	*1.270		*0.050	
b	0.330	0.510	0.013	0.020	L	0.400	1.270	0.016	0.050
c	0.170	0.250	0.006	0.010	θ	0°	8°	0°	8°
D	4.700	5.100	0.185	0.200					